# **SPECIFICATION**

SPEC. No. C-General-b

D A T E: 2014 June.

To

# **Non-Controlled Copy**

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

C Series / Commercial Grade

General (Up to 50V)

Mid voltage (100 to 630V)

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

# RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation
Sales
Electronic Components
Sales & Marketing Group

TDK-EPC Corporation
Engineering
Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

#### 1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan,

TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

#### **EXPLANATORY NOTE:**

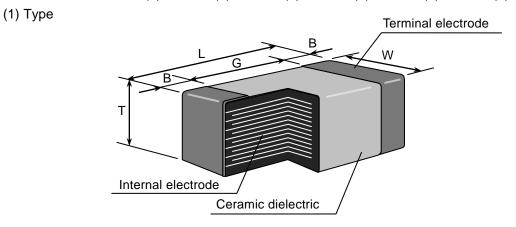
This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

#### 2. CODE CONSTRUCTION

(Example)

Catalog Number : (Web)	<u>C2012</u> (1)	(2)	1E (3)	<u>105</u> (4)	<u>K</u> (5)	<u>125</u> (6)	$\frac{A}{(7)}$ $\frac{A}{(8)}$
Item Description :	C2012 (1)	X7R (2)	<u>1E</u> (3)	<u>105</u> (4)	<u>K</u> (5)	<u>T</u> (9)	<u>xxxx</u> (10)



Please refer to product list for the dimension of each product.

(2) Temperature Characteristics (Details are shown in table 1 No.7 and No.8 at page 5)

(3) Rated Voltage

Symbol	Rated Voltage			
2 J	DC 630 V			
2 W	DC 450 V			
2 V	DC 350 V			
2 E	DC 250 V			
2 A	DC 100 V			
1 H	DC 50 V			
1 V	DC 35 V			
1 E	DC 25 V			
1 C	DC 16 V			
1 A	DC 10 V			
0 J	DC 6.3 V			
0 G	DC 4V			



## (4) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 2R2 → 2.2pF

105 → 1,000,000pF

(5) Capacitance tolerance

Symbol	Tolerance	Capacitance
В	± 0.1 pF	
С	± 0.25 pF	10pF and under
D	± 0.5 pF	
J	± 5%	
K	± 10 %	Over 10pF
М	± 20 %	

- (6) Thickness code (Only Catalog Number)
- (7) Package code (Only Catalog Number)
- (8) Special code (Only Catalog Number)
- (9) Packaging (Only Item Description)

Symbol	Packaging
В	Bulk
Т	Taping

(10) Internal code (Only Item Description)

#### 3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

#### 3.1 Standard combination of rated capacitance and tolerances

Class	Temperature Characteristics	Capacitance tolerance		Rated capacitance
	C H C0G	10pF and	B (±0.1 pF) C (±0.25pF)	0.5, 1, 1.5, 2, 2.2, 3, 3.3, 4, 4.7, 5
1		under C H	D (±0.5pF)	6, 6.8, 7, 8, 9, 10
		12pF to 10,000pF	J (± 5 %) K (± 10 %)	E – 12 series
		Over 10,000pF		E – 6 series
	J B X5R	10uF and	K (± 10 %)	
2	X6S	under	M (± 20 %)	E – 6 series
	X7R X7S X7T	Over 10uF	M (± 20 %)	E - 0 Series

#### 3.2 Capacitance Step in E series

E series		Capacitance Step										
E- 3	1.0			2.2			4.7					
E- 6	1.	.0	1	.5	2	.2	3	.3	4.	.7	6	.8
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

#### 4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
C H J B	-25°C	85°C	20°C
X5R	-55°C	85°C	25°C
X6S	-55°C	105°C	25°C
X7R X7S X7T C0G	-55°C	125°C	25°C

#### 5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

#### 6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225, C4532 and C5750 types are more likely to be affected by heat stress from the substrate.

Please inquire separate specification for the large case sizes when mounted on the substrate.

#### 7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.



## 8. PERFORMANCE

table 1

No.	Item	Perforr	Test or inspection method				
1	External Appearance	No defects which performance.	Inspect with magnifying glass (3x), in case of C0402 and C0603 type, with magnifying glass (10x)				
2	Insulation Resistance	$10,000 M\Omega$ or $500 M$ (As for the capacity voltage 16, $10 V$ DO $10,000 M\Omega$ or $100 M$ whichever smaller.	Apply ra	ted voltage f	or 60s.		
3	Voltage Proof	Withstand test volt	age without		1		
		insulation breakdo	wn or other	Class	Rated volta	ge Appl	y voltage
		damage.			100V and un	der 3 x rat	ted voltage
				Class1	Over 100\ 500V and un	1 1 5 v rs	ated voltage
					Over 500\	/ 1.3 × ra	ated voltage
					100V and un	der 2.5 x ra	ated voltage
				Class2	Over 100\ 500V and un	15 x ra	ated voltage
					Over 500\		ated voltage
					C voltage sh	nall be appl	ied for
				1s. Charge / exceed 5	discharge c 50mA.	urrent shal	l not
4	Capacitance	Within the specifie	d tolerance.				
				Class	Rated Capacitance	Measuring frequency	Measuring voltage
				Class1	1000pF and under Over 1000pF	1MHz±10% 1kHz±10%	- 0.5-5 Vms.
					10uF and	1kHz±10%	0.5±0.2Vms.
				Class2	under	TKI 12±1070	1.0±0.2Vms.
					Over 10uF	120Hz±20%	0.5±0.2Vms.
				measurir	mation whicl ng voltage, p presentative.	lease cont	
5	Q (Class1)	Rated Capacitance	Q	See No.4	4 in this table	e for measu	uring
	(Classi)	30pF and over	1,000 min.	Condition	1.		
		Under 30pF	400+20×C min.				
		C : Rated capacita	nce (pF)				
6	Dissipation Factor (Class2)	T.C.	D.F.	See No.4	4 in this table	e for measu	uring
		J B X5R X6S X7R X7S X7T	0.025 max. 0.03 max. 0.05 max. 0.075 max. 0.10 max. 0.15 max.	For infor Dissipati	mation whicl on Factor, pl presentative.	lease conta	



No.	Item	Perfo	rmance	Test or inspection method		
7	Temperature Characteristics of Capacitance (Class1)	T.C.  C H  C0G  Capacitance dri  Within ± 0.2% whichever large	or ±0.05pF,	Temperature coefficient shall be calculated based on values at 25°C an 85°C temperature.  Measuring temperature below 20°C sh be -10°C and -25°C.		
9	Temperature Characteristics of Capacitance (Class2)  Robustness of Terminations	No voltage applied  J B: ±10  X5R: ±15  X6S: ±22  X7R: ±15  X7S: ±22  X7T: +22  -33		Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step.  \[ \Delta \text{C} \text{ be calculated ref. STEP3 reading} \]  \[ \text{Step}  \text{ Temperature(°C)} \]  \[ \text{1}  \text{Reference temp. \pm 2} \]  \[ \text{2}  \text{Min. operating temp. \pm 2} \]  \[ \text{4}  \text{Max. operating temp. \pm 2} \]  \[ \text{Measuring voltage: 0.1, 0.2, 0.5, 1.0Vrms.} \]  For information which product has which applied voltage, please contact with our sales representative.  \[ \text{Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b and apply a pushing force of 2N (C0603, C1005) or 5N (C1608, C2012, C3216, C3225, C4532, C5750) with 10\pm 1s. \]  (Not applicable to C0402.)  \[ \text{Pushing force} \]  \[ \text{P.C.Board} \]		
10	Bending	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2a or Appendix 2b and bend it for 1mm.		

	_		
No.	Item	Performance	Test or inspection method
11	Solderability	(C0402)	Completely soak both terminations in
		Both end faces and the contact areas	solder at 235±5°C for 2 ± 0.5s.
		shall be covered with a smooth and	
		bright solder coating with no more than	Solder : H63A (JIS Z 3282)
		a small amount of scattered	
		imperfections such as pinholes or	Flux: Isopropyl alcohol (JIS K 8839)
		un-wetted or de-wetted areas.	Rosin (JIS K 5902) 25% solid
		These imperfections shall not be	solution.
		concentrated in one area.	
		(Others)	Only reflow soldering applicable to
		New solder to cover over 75% of termination.	C0402.
		25% may have pin holes or rough spots	Peak condition
		but not concentrated in one spot.	Temp. : 235±5°C
	Ceramic surface of A sections shall not		Time: 2±0.5s.
		be exposed due to melting or shifting of	Preheating condition
		termination material.	Temp. : 150±10°C
		A section	Time: 1 to 2min.



No.	Ite	em		Perfo	rmance	Test or inspection method	
12	Resistance to solder heat	External appearance	terminati	ons sha	llowed and all be covered at new solder.	Completely soak both terminations in solder at 260±5°C for 5±1s.	
		Capacitance	Charact	teristics	Change from the value before test	Preheating condition Temp.: 150±10°C Time: 1 to 2min.	
			Class 1	C H COG	Capacitance drift within ±2.5% or ±0.25pF, whichever larger.	Solder : H63A (JIS Z 3282)	
			Class 2	J B X5R X6S X7R X7S X7T	±7.5 % ±7.5 % ±7.5 % ±7.5 % ±7.5 %	Flux: Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
				7.7.1	11.0 //	Leave the capacitors in ambient  condition for 6 to 24h (Class1) or 24±	
		Q (Class1)	Rated C	apacitance	e Q	(Class2) before measurement.	
			Unde	and over er 30pF	1,000 min. 400+20×C min.	Only reflow soldering applicable to C0402.	
					ritance (pF)	Peak condition	
		D.F. (Class2)	Meet the	initial s	spec.	Temp. : 235±5°C Time: 2±0.5s.	
		Insulation Resistance	Meet the initial spec.			Preheating condition Temp. : 150±10°C	
		Voltage proof	No insula damage.		eakdown or other	Time : 1 to 2min.	
3	Vibration	External appearance	No mech	nanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or	
		Capacitance	Charact	teristics	Change from the value before test	Appendix 1b before testing.	
			Class1	CH COG JB	±2.5% or ±0.25pF, whichever larger. ± 7.5 %	Vibrate the capacitors with amplitude of 1.5mm P-P changing the frequencies from 10Hz to 55Hz and	
			Class2	X5R X6S X7R X7S X7T	±7.5 % ±7.5 % ±7.5 % ±7.5 % ±7.5 %	back to 10Hz in about 1min.  Repeat this for 2h each in 3  perpendicular directions.	
		Q				_	
		(Class1)	Rated Capacitance Q  30pF and over 1,000 min.  Under 30pF 400+20xC min.				
					1,000 min. 400+20×C min.		
				•	ritance (pF)		
		D.F. (Class2)	Meet the	initial s	spec.		



No.	Ite	em		Perfo	rmance		Test or inspection m	nethod	
14	Temperature cycle	External appearance	No mechanical damage.				solder the capaciton pard shown in Appen		
		Capacitance	Characteristics  Change from the value before test  Class1  CH  Class1  CH  ±2.5% or ±0.25pF,		Appendix1b before testing.  Expose the capacitors in the condition step1 through step 4 and repeat 5 times				
			*Class2	JB X5R X6S X7R X7S	± 7.5 % ± 10 % ± 12.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class 1) or 24±2h (Class 2) before measurement.			
			* Applied for some parts.			Step	Temperature(°C)	Time (min.)	
		Q (Class1)				1	Min. operating temp. ±3	30 ± 3	
			Rated Ca 30pF ar	nd over	1,000 min.	2	Reference Temp.	2 - 5	
				Under 30pF 400+20xC min.  C: Rated capacitance (pF)		3	Max. operating temp. ±2	30 ± 2	
		D.F. (Class2)	Meet the	initial s	pec.	4	Reference Temp.	2 - 5	
		Insulation Resistance	Meet the	initial s	pec.				
		Voltage proof	No insulati	tion bre	eakdown or other				

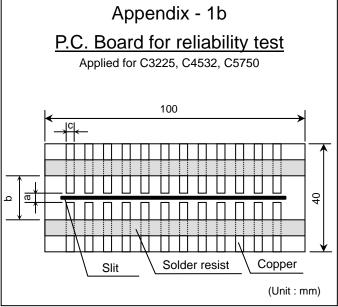
No.	Ite	em		Perfor	mance	Test or inspection method
15	Moisture Resistance	External appearance	No mechanical damage.			Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or
	(Steady	Capacitance				Appendix 1b before testing.
	State)		Characte	eristics	Change from the value before test	Leave at temperature 40 ± 2°C, 90 to
			Class1		±5% or ±0.5pF, whichever larger.	95%RH for 500 +24,0h.
			*Class2	JB X5R X6S X7R X7S X7T	± 10 % ± 12.5 % ± 25 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24 ± 2h (Class2) before measurement.
			* Applied fo	r some p	parts.	
		Q				1
		(Class1)	Rated Ca	pacitanc	e Q	
			30pF a	nd over	350 min.	
			10pF and over under 30pF		275+5/2×C min.	
			Under	10pF	200+10×C min.	
			C : Rated	capacita	ance (pF)	
		D.F. (Class2)	200% of in	itial spe	c. max.	-
		Insulation	1,000ΜΩ ο	r 50MΩ· <sub>l</sub>	uF min.	1
		Resistance	(As for the	capaci	tors of rated	
			voltage 16	, 10V D	C and lower,	
			1,000 ΜΩ	or 10M	Ω·μF min.,)	
			whichever	smalle		

No.	It	em		Perfo	rmance	Test or inspection method
16	Moisture Resistance	External appearance	No mecha	inical d	amage.	Reflow solder the capacitors on a P.C.Board shown in Appendix1a or
	Resistance	Q (Class1)	Unde	C H C0G  J B X5R X6S X7R X7S X7T or some  apacitane apacitane apacitane apacitane apacitane apacitane apacitane apacitane	ce Q 200 min. 100+10/3×C min. tance (pF)	Appendix 1b before testing.  Apply the rated voltage at temperature 40±2°C and 90 to 95%RH for 500 +24,0h.  Charge/discharge current shall not exceed 50mA.  Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.  Voltage conditioning (only for class 2) Voltage treat the capacitors under testing temperature and voltage for 1 hour.  Leave the capacitors in ambient condition for 24±2h before measurement.
		(Class2) Insulation Resistance	voltage 16	e capac 5, 10V [	·µF min. itors of rated DC and lower, 500 nin.,) whichever	Use this measurement for initial value.

No.	It	tem		Perfo	rmance	Test or inspection method			
17	Life	External appearance	No mecha	nical da	amage.	Reflow solder the capacitors on a P.C.Board shown in Appendix1a or Appendix 1b before testing.			
		Capacitance	Characte	eristics	Change from the value before test	Below the voltage shall be applied at maximum operating temperature ±2°C			
		Class1 C H ±3% or ±0.3pF, cog whichever larger. maximum operatin for 1,000 +48, 0h.							
				JB		Applied voltage			
			*Class2	X5R X6S	± 10 % ± 12.5 %	Rated voltage x2			
			Classz	X7R X7S	± 12.5 % ± 25 %	Rated voltage x1.5			
				X7T		Rated voltage x1.2			
			* Applied fo	r some	oarts.	Rated voltage x1			
		Q (Class1)	Rated Ca	apacitance	. Q	For information which product has			
		(Glade I)	30pF and over		350 min.	which applied voltage, please contact			
			•	over unde	275+5/2×C min.	with our sales representative.			
			30pF   270122011111.			Charge/discharge current shall not			
						exceed 50mA.			
		D.F.	200% of in	nitial spe	ec. max.	Leave the capacitors in ambient condition for 6 to 24h (Class1) or			
		(Class2)	200,000			24±2h (Class2) before measurement.			
		Insulation	1,000ΜΩ ο	r 50MΩ·	μF min.	Voltage conditioning (only for class 2)			
		Resistance	`	•	tors of rated	Voltage treat the capacitors under			
			_		C and lower,	testing temperature and voltage for 1			
					Ω·μF min.,) r	hour.			
			whichever smaller.			Leave the capacitors in ambient			
						condition for 24±2h before measurement.			
						Use this measurement for initial value.			
						Ose this measurement for initial value.			

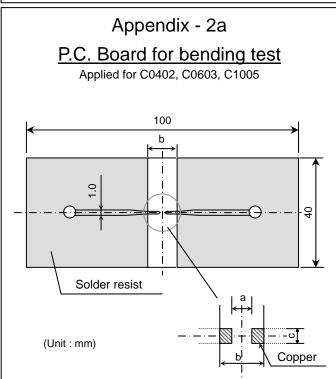
<sup>\*</sup>As for the initial measurement of capacitors (Class2) on number 8,12,13,14 and 15, leave capacitors at 150 -10,0 $^{\circ}$ C for 1 hour and measure the value after leaving capacitors for 24 ± 2h in ambient condition.

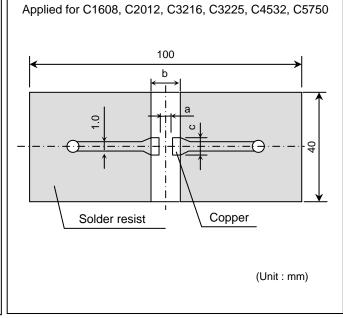
# Appendix - 1a P.C. Board for reliability test Applied for C0402, C0603, C1005, C1608, C2012, C3216



Appendix - 2b

P.C. Board for bending test





Material : Glass Epoxy ( As per JIS C6484 GE4 )

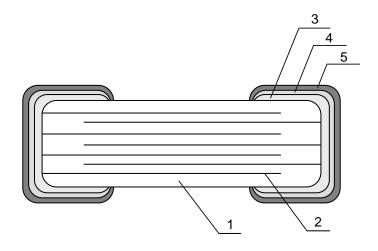
P.C. Board thickness : Appendix-2a 0.8mm
Appendix-1a, 1b, 2b 1.6mm

Copper ( thickness 0.035mm )
Solder resist

TDV (FIA atula)	Dime	ensions (n	nm)
TDK (EIA style)	а	b	С
C0402 (CC01005)	0.2	0.8	0.2
C0603 (CC0201)	0.3	0.8	0.3
C1005 (CC0402)	0.4	1.5	0.5
C1608 (CC0603)	1.0	3.0	1.2
C2012 (CC0805)	1.2	4.0	1.65
C3216 (CC1206)	2.2	5.0	2.0
C3225 (CC1210)	2.2	5.0	2.9
C4532 (CC1812)	3.5	7.0	3.7
C5750 (CC2220)	4.5	8.0	5.6



# 9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL					
NO.	INAIVIE	Class1	Class2				
1	Dielectric	CaZrO <sub>3</sub> BaTiO <sub>3</sub>					
2	Electrode	Nickel (Ni)					
3		Copper (Cu)					
4	Termination	Nickel (Ni)					
5		Tin (Sn)					

## 10. RECOMMENDATION

As for C3225, C4532 and C5750 types, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

# 11. SOLDERING CONDITION

As for C0402, C0603, C1005, C3225, C4532 and C5750 types, reflow soldering only.



# 12. Caution

	Lo Process Condition						
No.	Process	Condition					
1	Operating Condition (Storage, Transportation)	<ol> <li>1-1. Storage</li> <li>The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.</li> <li>The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate Chlorine, Ammonia and sulfur.</li> <li>Avoid storing in sun light and falling of dew.</li> <li>Do not use capacitors under high humidity and high and low atmospheric press which may affect capacitors reliability.</li> <li>Capacitors should be tested for the solderability when they are stored for long ti 1-2. Handling in transportation         In case of the transportation of the capacitors, the performance of the capacitor may be deteriorated depending on the transportation condition.         (Refer to JEITA RCR-2335B 9.2 Handling in transportation)     </li> </ol>					
2	Circuit design  ⚠ Caution	2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.  1) Do not use capacitors above the maximum allowable operating temperature. 2) Surface temperature including self heating should be below maximum operating temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)  3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.  2-2. Operating voltage  1) Operating voltage across the terminals should be below the rated voltage.  When AC and DC are super imposed, V <sub>0-P</sub> must be below the rated voltage.  — (1) and (2) AC or pulse with overshooting, V <sub>P-P</sub> must be below the rated voltage.  — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.  Voltage  1) DC voltage  1) DC voltage  2) DC+AC voltage  3) AC voltage  Voltage  4) Positional Measurement (Rated voltage)  Voltage  (4) Pulse voltage (A) (5) Pulse voltage (B)					

No.	Process	Condition								
2	Circuit design  A Caution	1	2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.							
	<u> </u>	The capacitor	<ol> <li>The effective capacitance will vary depending on applied DC and AC voltages.</li> <li>The capacitors should be selected and designed in taking the voltages into consideration.</li> </ol>							
		2-3. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.								
3	Designing P.C.board	capacitors.  1) The greater the and the more shape and size terminations.  2) Avoid using contacts.	1) The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the							
			or each termin							
		3) Size and reco	ommended lar							
				Chi	o capacit /	ors S	older la	nd		
		Solder resist							er resist	
			В	<b>→</b>	Α	$\rightarrow$				
		Flow solder	<del>-</del>		1				(mm	<u>n)</u>
		Type Symbol	C1608 (CC060			C2012 C0805	)	C3216 (CC120		
		A	0.7 - 1	.0	1.	0 - 1.3		2.1 - 2	.5	
		В	0.8 - 1	.0	1.	0 - 1.2		1.1 - 1.	.3	<u> </u>
		C	0.6 - 0	.8	0.	8 - 1.1		1.0 - 1	.3	<u>—</u>
		Reflow sold	ering							(mm)
		Туре	C0402		0603		005	C160		C2012
		Symbol	(CC01005)		0201)		0402)	(CC060		(CC0805)
		A R	0.15 - 0.25		5 - 0.35		- 0.5 - 0.45	0.6 - 0		0.9 - 1.2
		B 0.15 - 0.25 0.2 - 0.3 0.35 - 0.45 0.6 - 0.8 0.7 - 0.9 C 0.15 - 0.25 0.25 - 0.35 0.4 - 0.6 0.6 - 0.8 0.9 - 1.2							0.9 - 1.2	
			0.15-0.25   0.25-0.35   0.4-0.6   0.6-0.8   0.9-1.2							
		Type C3216 C3225 C4532 C5750 (CC1206) (CC1210) (CC1812) (CC2220)								
		A	2.0 - 2.4		2.0 - 2		3.1	- 3.7		4.1 - 4.8
		В	1.0 - 1.2		1.0 - 1			- 1.4		1.2 - 1.4
		C	1.1 - 1.6		1.9 - 2	2.5	2.4	- 3.2		4.0 - 5.0

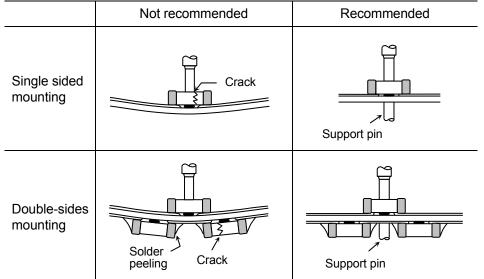
No.	Drococ		Condition	
No. 3	Process  Designing P.C.board	4) Recommended	Condition  chip capacitors layout is as follows:	wing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit  Break P.C.board with	Perforation or slit  Break P.C.board with
			mounted side up.	mounted side down.
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit  Perforation or slit	Mount in parallel with perforation or slit  Perforation or slit
		Distance from slit	Closer to slit is higher stress $(\mathcal{L}_1 < \mathcal{L}_2)$	Away from slit is less stress $\ell_2$ $(\ell_1 < \ell_2)$

No. **Process** Condition 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. 3 Designing P.C.board E Perforation ၁ဝဝဝီဝင 00000 в Slit The stress in capacitors is in the following order. A > B = C > D > E

## 6) Layout recommendation

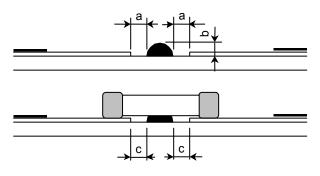
Example	Use of common solder land	Soldering with chassis	Use of common solder land with other SMD		
Need to avoid	Lead wire Chip Solder PCB Adhesive Solder land	Chassis Excessive solder	Solder land  Excessive solder  Missing solder land		
Recommen- dation	Solder resist	Solder resist $\ell^2$ $\ell^2 > \ell^1$	Solder resist		

No.	Process	Condition					
4	Mounting	duce excessive stress in the chip					
		surface and not 2) Adjust the mount 3) To minimize the	nting head pressure to be 1 to 3N e impact energy from mounting hea	of static weight.			
		See following e	e bottom side of the P.C.board. xamples.  Not recommended	Recommended			



When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

## 4-2. Amount of adhesive



Example: C2012 (CC0805), C3216 (CC1206)

а	0.2mm min.		
b 70 - 100μm			
С	Do not touch the solder land		



No.	Process		Сс	ondition				
5	<ul> <li>5-1. Flux selection     Although highly-activated flux gives better solderability, substances which i activity may also degrade the insulation of the chip capacitors. To avoid sur degradation, it is recommended following.</li> <li>1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% Strong flux is not recommended.</li> <li>2) Excessive flux must be avoided. Please provide proper amount of flux.</li> <li>3) When water-soluble flux is used, enough washing is necessary.</li> </ul>							
		5.2 Perommended sold	ering profile by y	various method	le.			
		5-2. Recommended soldering profile by various methods  Wave soldering  Soldering  Preheating  Natural cooling  Preheating  Natural cooling						
Peak Temp Under 100 Soldering Natural cooling Preheat Temp (O) Over 60 sec.  Peak Temp time  Manual soldering (Solder iron)  As for C1608 and C3216 (0 soldering and As for C0402 C1005 (CCO.				Preheating Natural cooling  60 sec. Peak Temp time  CATION C1608 (CC0603), C2012 (CC0805) 3216 (CC1206), applied to wave ng and reflow soldering. C0402 (CC01005), C0603 (CC0201), (CC0402), C3225 (CC1210), C4532 12), C5750 (CC2220), applied only to				
		5-3. Recommended sold	ering peak temp	and peak tem	p duration			
		Temp./Duration	Wave so	oldering	Reflow so	oldering		
		Solder	Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)		
		Sn-Pb Solder 250 max. 3 max. 230 max. 20						
		Lead Free Solder	260 max.	5 max.	260 max.	10 max.		
		Recommended solds Sn-37Pb (Sn-Pb sol Sn-3.0Ag-0.5Cu (Le	lder)					



	Process		Condition		
5	Soldering	5-4. Avoiding thermal shock	<b>(</b>		
		Preheating condition			
		Soldering	Туре		Temp. (°C)
		Wave soldering	C1608(CC0603), C2012 C3216(CC1206)	2(CC0805),	ΔT ≤ 150
		D. fl.	C0402(CC01005),C0603 C1005(CC0402), C1608	(CC0603),	ΔT ≤ 150
		Reflow soldering	C2012(CC0805), C3216 C3225(CC1210), C4532 C5750(CC2220)		ΔT ≤ 130
		Manual soldering	C0402(CC01005),C0603 C1005(CC0402), C1608 C2012(CC0805), C3216	(CC0603),	ΔT ≤ 150
			C3225(CC1210), C4532 C5750(CC2220)		ΔT ≤ 130
		5-5. Amount of solder  Excessive solder v  temperature change	ure difference (ΔT) must will induce higher tenses and it may result in charters from the P.C.board.	ile force ir	n chip capacitors whe
		Excessive solder			ner tensile force in capacitors to cause k
		Adequate		Maximum	amount
				Minimum	
		Insufficient solder		Low caus	
		Insufficient solder  5-6. Solder repair by solder  1) Selection of the solderir Tip temperature of sold land size. The higher theat shock may cause Please make sure the time in accordance with		Low caus chip the the cacitors.  Ing and keep ed condition	robustness may se contact failure or capacitors come off P.C.board.  I material and solder operation. However, the peak temp and (Please preheat the
		Insufficient solder  5-6. Solder repair by solder  1) Selection of the solderir Tip temperature of sold land size. The higher theat shock may cause Please make sure the time in accordance with chip capacitors with the Recommended solder.	ng iron tip der iron varies by its type he tip temperature, the c e a crack in the chip capa tip temp. before solderir th following recommende e condition in 5-4 to avo er iron condition (Sn-Pb S	Low cause chip the decitors.  Ing and keep ed condition id the therm	robustness may se contact failure or capacitors come off P.C.board.  I material and solder operation. However, the peak temp and (Please preheat the lal shock.)  Lead Free Solder)
		Insufficient solder  5-6. Solder repair by solder  1) Selection of the solderir Tip temperature of sold land size. The higher theat shock may cause Please make sure the time in accordance with chip capacitors with the	ng iron tip der iron varies by its type he tip temperature, the c e a crack in the chip capa tip temp. before solderir th following recommende e condition in 5-4 to avo er iron condition (Sn-Pb S	Low cause chip the decitors.  Ing and keep ed condition id the therm	robustness may se contact failure or capacitors come off P.C.board.  I material and solder operation. However, the peak temp and (Please preheat the pal shock.)

No.	Process	Condition
5	Soldering	<ol> <li>Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.</li> <li>5-7. Sn-Zn solder         Sn-Zn solder sproduct reliability.         Please contact TDK in advance when utilize Sn-Zn solder.</li> <li>5-8. Countermeasure for tombstone         The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering.         (Refer to JEITA RCR-2335B Annex 1 (Informative) Recommendations to prevent the tombstone phenomenon)</li> </ol>
6	Cleaning	<ol> <li>If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.</li> <li>If cleaning condition is not suitable, it may damage the chip capacitors.</li> <li>Insufficient washing         <ul> <li>Terminal electrodes may corrode by Halogen in the flux.</li> </ul> </li> <li>Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.</li> <li>Water soluble flux has higher tendency to have above mentioned problems (1) and (2).</li> <li>Excessive washing         When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.         Power: 20 Wl ≠ max.         Frequency: 40 kHz max.</li></ol>

	_								
No.	Process	4) ) ) (1	Condition  1) When the P.C.board is coated, please verify the quality influence on the product.						
7	Coating and molding of the P.C.board	2) Please ve emission	<ul><li>2) Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li><li>3) Please verify the curing temperature.</li></ul>						
8	Handling after chip mounted  A Caution	1) Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack.  Bend  Twist  2) When functional check of the P.C.board is performed, check pin pressure tends to be adjusted higher for fear of loose contact. But if the pressure is excessive and bend the P.C.board, it may crack the chip capacitors or peel the terminations off. Please adjust the check pins not to bend the P.C.board.							
		Board bending	Not recommended  Termination peeling  Check pin	Recommended  Support pin  Check pin					
9	Handling of loose chip capacitors	the large handle wi		e or handling, the corner of the P.C.					

No.	Process	Condition
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
12	Others  A Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		<ul> <li>(1) Aerospace/Aviation equipment</li> <li>(2) Transportation equipment (cars, electric trains, ships, etc.)</li> <li>(3) Medical equipment</li> <li>(4) Power-generation control equipment</li> <li>(5) Atomic energy-related equipment</li> <li>(6) Seabed equipment</li> <li>(7) Transportation control equipment</li> <li>(8) Public information-processing equipment</li> <li>(9) Military equipment</li> <li>(10) Electric heating apparatus, burning equipment</li> <li>(11) Disaster prevention/crime prevention equipment</li> <li>(12) Safety equipment</li> <li>(13) Other applications that are not considered general-purpose applications</li> </ul>
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



# 13. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

\*Composition of Inspection No.

Example 
$$\underline{M}$$
  $\underline{2}$   $\underline{A}$  -  $\underline{OO}$  -  $\underline{OOO}$  (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

# 14. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging: 1,000pcs. As for C0402, C0603 and C1005 types, not available for bulk packaging.



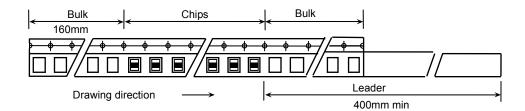
## 15. TAPE PACKAGING SPECIFICATION

#### 1. CONSTRUCTION AND DIMENSION OF TAPING

## 1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4. Dimensions of plastic tape shall be according to Appendix 5, 6.

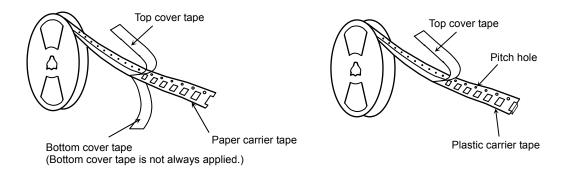
#### 1-2. Bulk part and leader of taping



#### 1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8. Dimensions of Ø330 reel shall be according to Appendix 9, 10.

## 1-4. Structure of taping





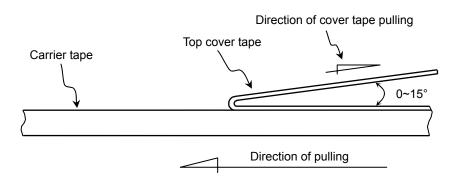
## 2. CHIP QUANTITY

T	Thickness	Taping	Chip quantity (pcs.)		
Type	of chip	Material	φ178mm reel	φ330mm reel	
C0402	0.20 mm	Paper	20,000	-	
C0603	0.30 mm	Paper	15,000	-	
C1005	0.50 mm	Paper	10,000	50,000	
C1608	0.80 mm	Paper	4,000	10,000	
	0.60 mm	Paper	4.000		
C2012	0.85 mm	Paper or Plastic	4,000	10,000	
	1.25 mm	Plastic	2,000		
	0.60 mm	Paper	4,000		
C3216	0.85 mm	Paper or Plastic	4,000	10.000	
	1.15 mm			10,000	
	1.30 mm	Plastic	2,000		
	1.60 mm			8,000	
	1.15 mm		2,000	10,000	
	1.25 mm				
	1.30 mm		2,000	8,000	
C3225	1.60 mm	Plastic			
	2.00 mm			5,000	
	2.30 mm		1,000		
	2.50 mm				
	1.60 mm		1,000		
	2.00 mm		1,000	3,000	
C4532	2.30 mm	Plastic		0,000	
04302	2.50 mm	1 lastic	500		
	2.80 mm		- 550	2,000	
	3.20 mm			2,000	
	2.00 mm				
C5750	2.30 mm	Plastic	500	3,000	
00100	2.50 mm				
	2.80 mm			2,000	



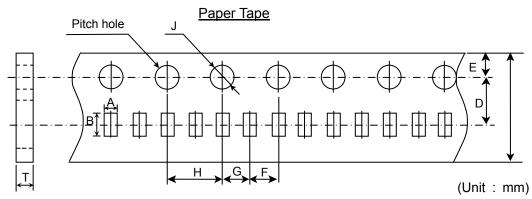
#### 3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape) 0.05-0.7N. (See the following figure.)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



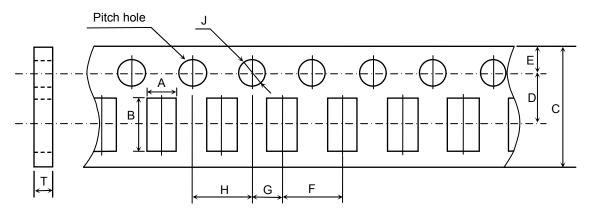


Symbol Type	А	В	С	D	E	F
C0402 (C01005)	(0.25)	(0.45)				
C0603 (CC0201)	( 0.38 )	( 0.68 )	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05
C1005 (CC0402)	( 0.65 )	(1.15)				

Symbol Type	G	Н	J	Т
C0402 (C01005)				0.29 min.
C0603 (CC0201)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 <sup>+0.10</sup>	0.40 min.
C1005 (CC0402)				0.60±0.15

<sup>\*</sup> The values in the parentheses ( ) are for reference.

# Paper Tape

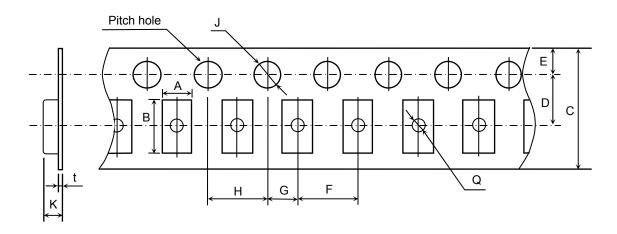


(Unit: mm)

Symbol Type	А	В	С	D	E	F
C1608 (CC0603)	(1.10)	(1.90)				
C2012 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3216 (CC1206)	(1.90)	(3.50)				
Symbol Type	G	Н	J	Т		
C1608 (CC0603)						
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	1.10 max.		
C3216						

<sup>\*</sup> The values in the parentheses ( ) are for reference.

# Plastic Tape



(Unit:mm)

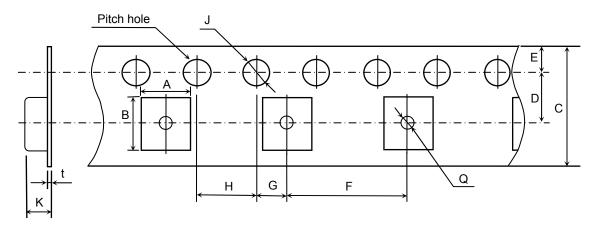
Symbol Type	А	В	С	D	E	F
C2012 (CC0805)	( 1.50 )	(2.30)	9 00 1 0 30	2 50 ± 0 05		
C3216 (CC1206)	( 1.90 )	(3.50)	8.00 ± 0.30 [12.0 ± 0.30]	3.50 ± 0.05 [5.50 ± 0.05]	1.75 ± 0.10	4.00 ± 0.10
C3225 (CC1210)	( 2.90 )	(3.60)	[12.0 1 0.00]	[0.00 ± 0.00]		
Symbol Type	G	Н	J	K	t	Q
C2012 (CC0805)				2.50 max.	0.30 max.	
C3216 (CC1206)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	2.50 IIIax.	0.50 IIIax.	Ø 0.50 min.
C3225 (CC1210)				3.20 max.	0.60 max.	

<sup>\*</sup> The values in the parentheses ( ) are for reference.



<sup>\*</sup> As for 2.5mm thickness products, apply values in the brackets [ ].

# Plastic Tape



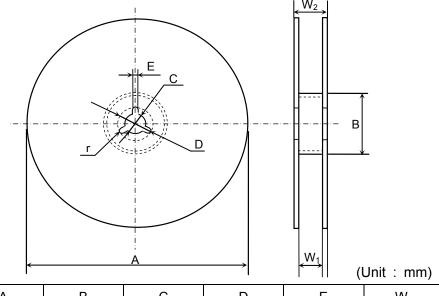
(Unit:mm)

Symbol Type	А	В	С	D	E	F
C4532 (CC1812)	(3.60)	(4.90)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
C5750 (CC2220)	(5.40)	(6.10)	12.0 ± 0.50	3.30 ± 0.03	1.75 ± 0.10	6.00 ± 0.10
Symbol Type	G	Н	J	К	t	Q
C4532 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	6.50 max.	0.60 max.	Ø 1.50 min.
C5750 (CC2220)	2.00 1 0.03	4.00 ± 0.10	0 1.5	0.50 IIIax.	0.00 IIIax.	Ø 1.30 mm.

<sup>\*</sup> The values in the parentheses ( ) are for reference.



C0402, C0603, C1005, C1608, C2012, C3216, C3225 ( As for C3225 type, any thickness of the item except 2.5mm ) (Material : Polystyrene)

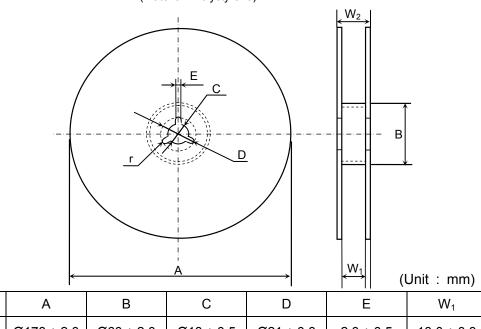


Symbol	А	В	С	D	Е	$W_1$
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W <sub>2</sub>	r	
Dimension	13.0 ± 1.4	1.0	

## **Appendix 8**

C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products ) (Material : Polystyrene)

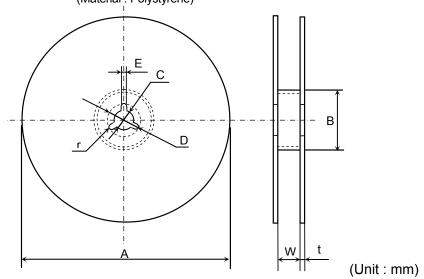


Symbol	Α	В	С	D	Е	$W_1$
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

Symbol	$W_2$	r	
Dimension	17.0 ± 1.4	1.0	



C0603, C1005, C1608, C2012, C3216, C3225 (As for C3225 type, any thickness of the item except 2.5mm ) (Material : Polystyrene)

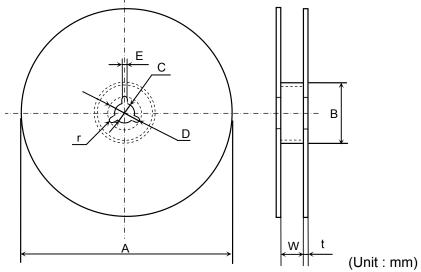


Symbol	А	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r
Dimension	$2.0 \pm 0.5$	1.0

# **Appendix 10**

C3225, C4532, C5750 (As for C3225 type, applied to 2.5mm thickness products ) (Material : Polystyrene)



Symbol	А	В	С	D	Е	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0